



CPC3730 N-Channel Depletion-Mode FET

PRELIMINARY

BV _{DSX} / BV _{DGX}	R _{DS(ON)} (max)	I _{DSS} (min)	Package
350V _P	30Ω	140mA	SOT-89

Features

• Low $R_{DS(ON)}$ at Cold Temperatures • $R_{DS(on)}$ 30 Ω max. at 25°C

High Input Impedance

High Breakdown Voltage: 350V_P

Low V_{GS(off)} Voltage: -1.6 to -3.9V

Small Package Size: SOT-89

Applications

- Ignition Modules
- Normally-On Switches
- Solid State Relays
- Converters
- Telecommunications
- Power Supply

Description

The CPC3730 is an N-channel, depletion mode, field effect transistor (FET) that utilizes Clare's proprietary third-generation vertical DMOS process. The third-generation process realizes world class, high voltage MOSFET performance in an economical silicon gate process. Our vertical DMOS process yields a robust device, with high input impedance, for use in high power applications. The CPC3730 is a highly reliable FET device that has been used extensively in Clare's solid state relays for industrial and telecommunications applications.

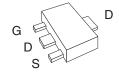
This device excels in power applications requiring low drain-source resistance, particularly in cold environments such as automotive ignition modules. The CPC3730 offers a low, 30Ω maximum, on-state resistance at 25°C.

The CPC3730 has a minimum breakdown voltage of 350V_P, and is available in an SOT-89 package. As with all MOS devices, the FET structure prevents thermal runaway and thermal-induced secondary breakdown.

Ordering Information

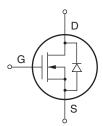
Part #	Description
CPC3730CTR	SOT-89 (1000/Reel)

Package Pinout



(SOT-89)

Circuit Symbol











Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Drain-to-Source Voltage	350	V_{P}
Gate-to-Source Voltage	±20	V_{P}
Total Package Dissipation	1.6 ¹	W
Operational Temperature	-55 to +125	°C
Storage Temperature	-55 to +125	°C

¹ Mounted on FR4 board 1"x1"x0.062"

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

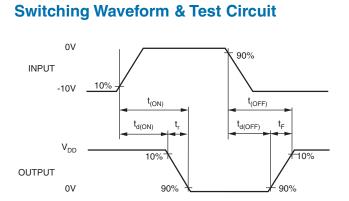
Electrical Characteristics @ 25°C (Unless Otherwise Noted)

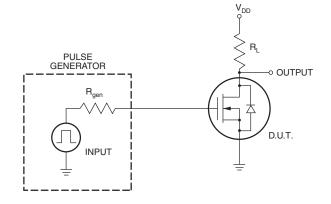
Parameter	Symbol	Conditions	Min	Тур	Max	Units
Drain-to-Source Breakdown Voltage	BV _{DSX}	V _{GS} = -5V, I _D =100μA	350	-	-	V _P
Gate-to-Source Off Voltage	V _{GS(off)}	I _{DS} = 15V, I _D =1mA	-1.6	-	-3.9	V
Change in V _{GS(off)} with Temperatures	dV _{GS(off)} /dT	V _{DS} = 15V, I _D =1mA	-	-	4.5	mV/°C
Gate Body Leakage Current	I _{GSS}	V_{GS} =±20V, V_{DS} =0V	-	-	100	nA
Drain-to-Source Leakage Current	_	V _{GS} = -5V, V _{DS} =Max Rating	-	-	1	μΑ
Dialit-to-Source Leakage Guiterit	I _{D(off)}	V _{GS} = -5V, V _{DS} =280V, T _A =125°C	-	-	1	mA
Saturated Drain-to-Source Current	I _{DSS}	V _{GS} = 0V, V _{DS} =15V	140mA	-	-	mA
Static Drain-to-Source On-State Resistance	R _{DS(on)}	V _{GS} = 0V, I _D =140mA	-	-	30	Ω
Change in R _{DS(on)} with Temperatures	dR _{DS(on)} /dT	V _{GS} = 0V, I _D =140mA	-	-	1.1	%/°C
Forward Transconductance	G _{FS}	I _D = 100mA, V _{DS} = 10V	150	-	-	тъ
Input Capacitance	C _{ISS}	V _{GS} = -5V		100	200	
Common Source Output Capacitance	C _{OSS}	V _{DS} = 25V	-	20	100	pF
Reverse Transfer Capacitance	C _{RSS}	f= 1MHz		5	80]
Turn-ON Delay Time	t _{d(on)}	V _{DD} = 25V		20		
Rise Time	t,	$I_{\rm D} = 150 {\rm mA}$		10		
Turn-OFF Delay Time	t _{d(off)}	V _{GS} = 0V to -10V	-	20	-	ns
Fall time	t _r	$R_{GEN} = 50\Omega$		50	1	
Source-Drain Diode Voltage Drop	V _{SD}	V _{GS} = -5V, I _{SD} = 150mA	-	0.6	1.8	V

Thermal Characteristics

Package	I _D (continuous)	I _D (pulsed)	Power Dissipation @T _A =25°C	θ _{jc} °C/W	I _{DR}	I _{DRM}
SOT-89	140mA	600mA	1.6W ¹	15	140mA	600mA

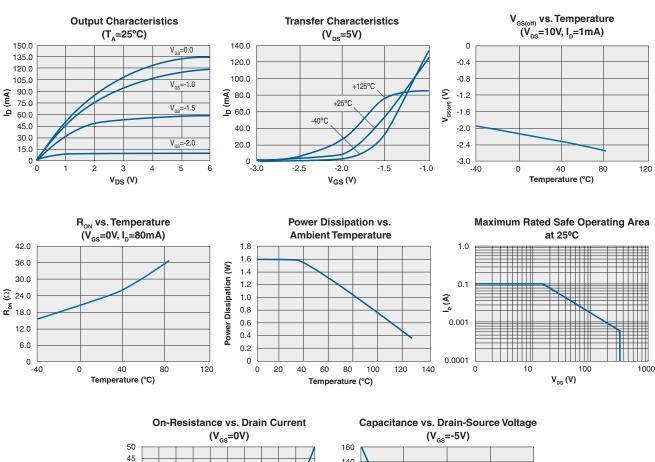
¹ Mounted on FR4 board 1"x1"x0.062"

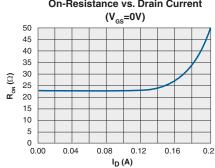


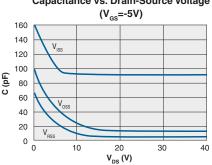




PERFORMANCE DATA*







^{*}The Performance data shown in the graphs above is typical of device performance. For guaranteed parameters not indicated in the written specifications, please contact our application department.



Manufacturing Information

Moisture Sensitivity



All plastic encapsulated semiconductor packages are susceptible to moisture ingression. Clare classified all of its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to

the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL) rating** as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Rating
CPC3730C	MSL 1

ESD Sensitivity



This product is ESD Sensitive, and should be handled according to the industry standard JESD-625.

Reflow Profile

This product has a maximum body temperature and time rating as shown below. All other guidelines of **J-STD-020** must be observed.

Device	Maximum Temperature x Time
CPC3730C	260°C for 30 seconds

Board Wash

Clare recommends the use of no-clean flux formulations. However, board washing to remove flux residue is acceptable. Since Clare employs the use of silicone coating as an optical waveguide in many of its optically isolated products, the use of a short drying bake may be necessary if a wash is used after solder reflow processes. Chlorine-based or Fluorine-based solvents or fluxes should not be used. Cleaning methods that employ ultrasonic energy should not be used.



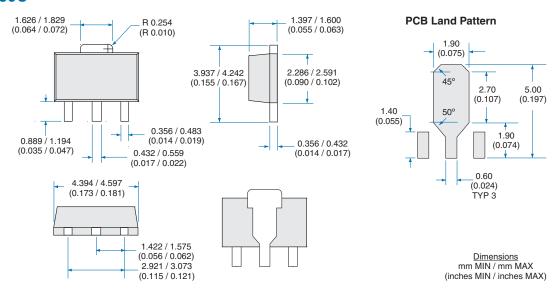




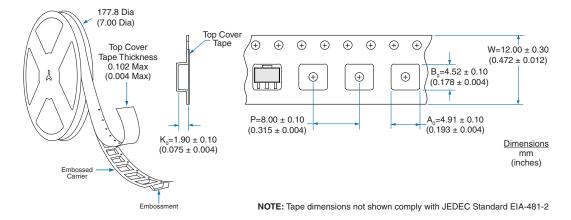


MECHANICAL DIMENSIONS

CPC3730C



CPC3730C Tape & Reel



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